

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10574445	STEER ET AL.
	Examiner	Art Unit
	YUK CHOW	2629

SEARCHED

Class	Subclass	Date	Examiner
345	76, 77, 205, 210, 211	3/12/2010	YC
702	189	3/12/2010	YC
257	59	3/12/2010	YC

SEARCH NOTES

Search Notes	Date	Examiner
drive transistor, drive voltage, interrupt, row driver, shift register, field period, duration.	3/12/2010	YC

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

--	--